

GB05SLT12-220

Silicon Carbide Power Schottky Diode

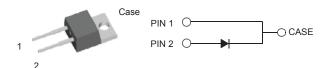
$\begin{array}{ccc} V_{RRM} & = & 1200 \text{ V} \\ I_{F} & = & 5 \text{ A} \\ Q_{C} & = & 19 \text{ nC} \end{array}$

Features

- 1200 V Schottky rectifier
- 175 °C maximum operating temperature
- · Zero reverse recovery charge
- Positive temperature coefficient of V_F
- · Extremely fast switching speeds
- · Temperature independent switching behavior
- Lowest figure of merit Q_C/I_F

Package

RoHS Compliant



TO - 220AC

Advantages

- Improved circuit efficiency (Lower overall cost)
- · Low switching losses
- Ease of paralleling devices without thermal runaway
- Smaller heat sink requirements
- Industry's lowest reverse recovery charge
- Industry's lowest device capacitance
- Ideal for output switching of power supplies
- Best in class reverse leakage current at operating temperature

Applications

- Power Factor Correction (PFC)
- Switched-Mode Power Supply (SMPS)
- Solar Inverters
- Wind Turbine Inverters
- Motor Drives
- Induction Heating
- Uninterruptible Power Supply (UPS)
- Voltage Clamping

Maximum Ratings, at T_i = 175 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values	Unit
Repetitive peak reverse voltage	V_{RRM}		1200	V
Continuous forward current	I _F	T _C ≤ 150 °C	5	Α
RMS forward current	I _{F(RMS)}	T _C ≤ 150 °C	8	Α
Surge non-repetitive forward current, Half Sine Wave	I _{F,SM}	$T_{_{\rm C}}$ = 25 °C, $t_{_{\rm p}}$ = 10 ms	tbd	А
Non-repetitive peak forward current	I _{F,max}	$T_{\rm C}$ = 25 °C, $t_{\rm p}$ = 10 µs	tbd	Α
i²t value	∫i² dt	$T_{c} = 25 ^{\circ}\text{C}, t_{p} = 10 \text{ms}$	tbd	A ² s
Power dissipation	P _{tot}	T _C = 25 °C	117	W
Operating and storage temperature	T _j , T _{stg}		-55 to 175	°C

Electrical Characteristics, at T_i = 175 °C, unless otherwise specified

Davamatar	Cumbal	Conditions	Values		11-24	
Parameter	Symbol	Conditions	min.	typ.	max.	Unit
Diado forward voltago	V	I _F = 5 A, T _j = 25 °C		1.70	1.8	\/
Diode forward voltage	v _F	I _F = 5 A, T _j = 175 °C		2.95		V
Deverse surrent	1	V _R = 1200 V, T _j = 25 °C		5	120	μA
Reverse current	¹R	V _R = 1200 V, T _j = 175 °C		20	1000	
Total capacitive charge	Q _c	$V_R = 950 \text{ V}, I_F \leq I_{F,max}$		19		nC
Switching time	t _s	$dI_{F}/dt = 330 \text{ A/}\mu\text{s}, T_{j} = 150 ^{\circ}\text{C}$		< 15		ns
Total capacitance	С	$V_R = 3 \text{ V, f} = 1 \text{ kHz, T}_j = 25 \text{ °C}$ 170			n.E	
	C	$V_R = 200 \text{ V, f} = 1 \text{ kHz, T}_j = 25 \text{ °C}$		31		pF

Thermal Characteristics

mermanesistance, junction - case	thJC	1.20	C/VV
Mechanical Properties			
Mounting torque	M	0.6	Nm

^{1.} Considering worst case Z_{th} conditions

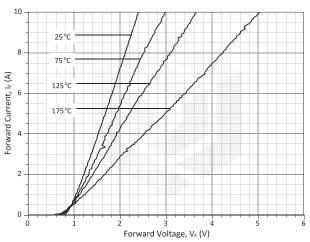


Figure 1: Typical Forward Characteristics

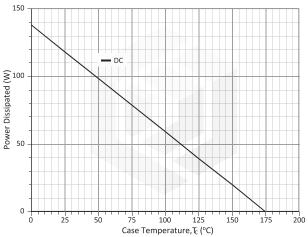


Figure 3: Typical Power Derating Curve

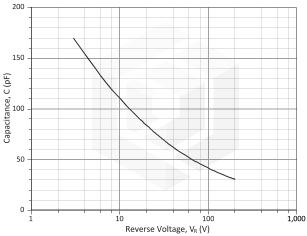


Figure 5: Typical Junction Capacitance versus Reverse Voltage Characteristics

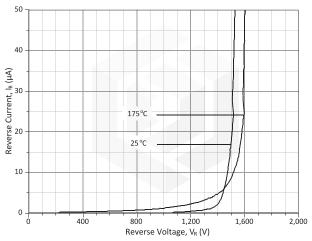


Figure 2: Typical Reverse Characteristics

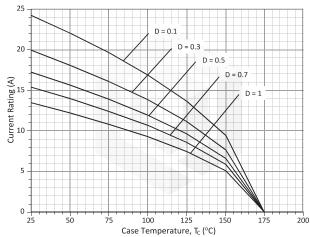


Figure 4: Typical Current Derating Curves (D = t_p/T , t_p = 400 μ s¹)

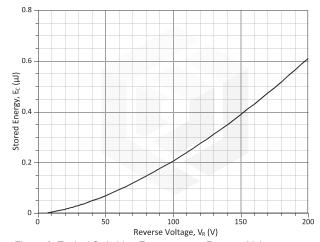
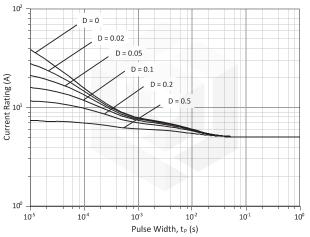


Figure 6: Typical Switching Energy versus Reverse Voltage Characteristics







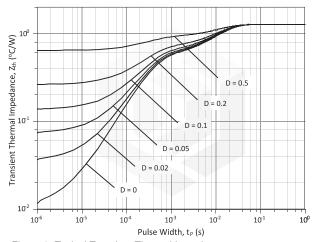
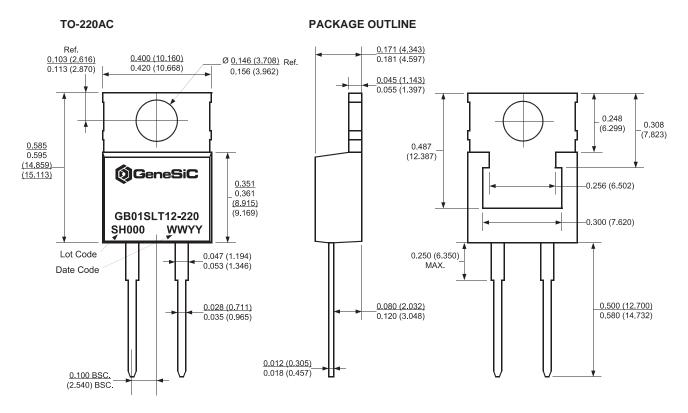


Figure 8: Typical Transient Thermal Impedance

Package Dimensions:



NOTE

- 1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
- 2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS





Revision History					
Date	Revision	Comments	Supersedes		
2010/12/14	1	Second generation release	GA05SLT12-220		

Published by GeneSiC Semiconductor, Inc. 43670 Trade Center Place Suite 155 Dulles, VA 20166

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